



High Volume Manufacturing Stimulus and Test for Inertial MEMS Devices

The ULTRA P is a high performance production handler that provides thermal conditioning, full 6 DOF mechanical stimulus and an electrical ATE signal path for testing Micro-Electro-Mechanical Systems (MEMS) Accelerometers and Gyroscopes.

The system is intended for high volume device manufacturing test, allowing up to 96 devices to be tested in parallel, but may also be used for verification, validation, and device engineering tasks.

The ULTRA P is a revolutionary step forward in device handling, thermal, mechanical stimulus and electrical signal performance.

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Accelerating MEMS Test Standards

- High UPH & Parallel Test Count
- Thermal Accuracy / Stability
- Aerospace Grade Rate / Position
- Signal Path Fidelity / Bandwidth
- Quick & Easy Change Kits

Key Test Features

- Full 6 DOF Test Capability
- Magnetic Test Option
- Packages Types: LGA, BGA, CSP
- Package Sizes: 2x2mm or larger
- UPH: 19,200 at Ambient or Temp.

ULTRA P Performance Specifications

ULTRA P	Feature	Details
Input / Output	JEDEC Tray	16X Pick & Place Input / Output
Carrier	Size	136mm x 136mm x 5mm 5.35" x 5.35" x 0.20"
	Device Parallel	2 to 96
Thermal Chamber	Temp Range	-40°C to +125°C, standard
	Resolution	0.1°C
	Accuracy	±1°C
	Stability	±0.2°C
	Heat Source	Electric Coil, 5200 watts
	Cold Source	LN2, 20-40 PSI
	Temp Control	PID Controller
	Temp Measure	User and Chamber Sensors
Rate Stimulus	Primary Axis	-360° to +360°
	Secondary Axis	-360° to +360°
	Third Axis	-360° to +360°
Constant Mode:	Acceleration	0.256º/Sec² to 4,500º/Sec²
	Rate (Velocity) Range	.0005º/Sec² to 1000º/Sec²
	Rate Accuracy	±0.01% of programmed value
	Repeatability	±5 Arc Seconds (.001°)
	Accuracy	±15 Arc Seconds (.005°)
Sinusoidal :	Speed/Velocity Range	10 to 1,000° / second
	Freq Range	1Hz to 20Hz
DUT IO	Number of Lines	800, 50Ω
IO Signals:	Bandwidth	>1.0GHz